# MOSFET - Power, Single, P-Channel, TSOP-6 -20 V, -5.9 A

#### **Features**

- Leading -20 V Trench for Low R<sub>DS(on)</sub>
- -1.8 V Rated for Low Voltage Gate Drive
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# **Applications**

- Power Load Switch
- High Side Load Switch
- Charging Circuits and Battery Protection

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

Paramet	Symbol	Value	Unit		
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	٧
Gate-to-Source Voltage			V <sub>GS</sub>	±8	V
Continuous Drain Current	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-5.1	Α
(Note 1)	State	T <sub>A</sub> = 85°C		-3.7	
	t ≤ 5 s	T <sub>A</sub> = 25°C		-5.9	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	1.19	W
	t≤5s			1.58	
Continuous Drain Current	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-3.8	Α
(Note 2)	State	T <sub>A</sub> = 85°C		-2.7	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	P <sub>D</sub>	0.65	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-20	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	105	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 1)	$R_{\theta JA}$	79	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	192	

- 1. Surface-mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq., 2 oz).
- 2. Surface-mounted on FR4 board using minimum pad size (Cu area = 0.0775 in sq.).

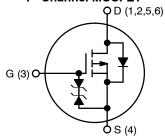


# ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Typ	I <sub>D</sub> MAX	
	22 mΩ @ -4.5 V		
-20 V	29 mΩ @ -2.5 V	–5.9 A	
	40 mΩ @ –1.8 V		

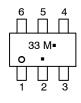
#### P-Channel MOSFET



#### MARKING DIAGRAM



TSOP-6 CASE 318G



33 = Specific Device Code

M = Date Code ■ Pb-Free Package

(Note: Microdot may be in either location)

# ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTGS3A033PZT1G	TSOP-6 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> =	–250 μΑ	-20			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = -250 μA, ref to 25°C			21		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			-1	μΑ
		$V_{DS} = -20 \text{ V}$	T <sub>J</sub> = 85°C			-10	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS}$	; = ±8 V			±10	μΑ
ON CHARACTERISTICS (Note 3)	•				•	•	
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = -250 μA		-0.4		-1.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				3		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = -4.5 V	I <sub>D</sub> = -5.1 A		22	33	mΩ
		V <sub>GS</sub> = -2.5 V	I <sub>D</sub> = -4.5 A		29	40	
		V <sub>GS</sub> = -1.8 V	I <sub>D</sub> = -1.5 A		40	55	
Forward Transconductance	9FS	$V_{DS} = -5 \text{ V}, I_D = -5 \text{ V}$	= -5.1 A		23		S
CHARGES AND CAPACITANCES	_					•	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = -10 V			1870		pF
Output Capacitance	C <sub>oss</sub>				203		
Reverse Transfer Capacitance	C <sub>rss</sub>				174		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -5.1 \text{ A}$			18.8		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.0		_
Gate-to-Source Charge	Q <sub>GS</sub>				2.7		
Gate-to-Drain Charge	$Q_{GD}$				5.0		
SWITCHING CHARACTERISTICS (Not	e 4)						
Turn-On Delay Time	t <sub>d(on)</sub>				9.4		ns
Rise Time	t <sub>r</sub>	Voc = -4 5 V Vo	s = -10 V		9.3		1
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -10 \text{ V},$ $I_{D} = -1.0 \text{ A}, R_{G} = 6.0 \Omega$			131		1
Fall Time	t <sub>f</sub>				56		
DRAIN-SOURCE DIODE CHARACTER							
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V},$ $I_{S} = -1.7 \text{ A}$	T <sub>J</sub> = 25°C		-0.7	-1.2	V
-			T <sub>J</sub> = 125°C		-0.6		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{SD}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = -1.7 \text{ A}$			26		ns
Charge Time	t <sub>a</sub>				9.0		1
Discharge Time	t <sub>b</sub>				17		1
Reverse Recovery Charge	Q <sub>RR</sub>				11	<del>                                     </del>	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Pulse Test: pulse width ≤ 300 ms, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

20

18

16

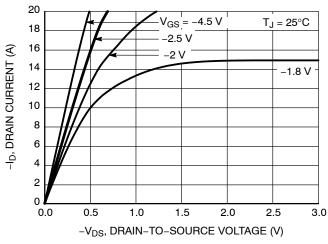
14

12

10

8

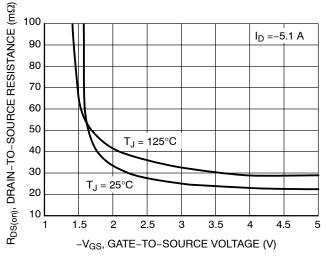
 $V_{DS} = -5 V$ 



-I<sub>D</sub>, DRAIN CURRENT (A)  $T_J = 125^{\circ}C$ 6  $T_J = 25^{\circ}C$ 4 2  $T_J = -55^{\circ}C$ 0.9 0.5 0.7 1.1 1.5 1.7 1.9 2.1

Figure 1. On-Region Characteristics

-V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V) Figure 2. Transfer Characteristics



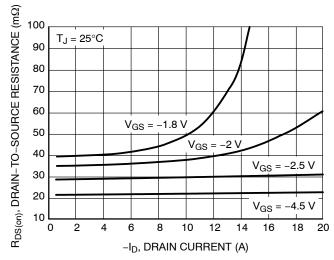
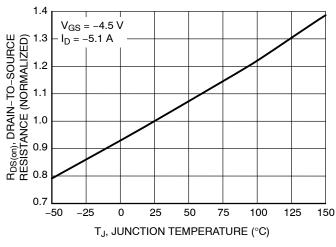


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 



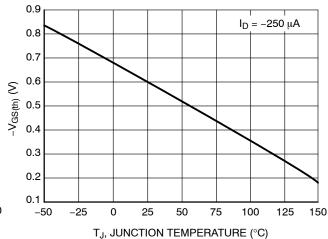


Figure 5. On-Resistance Variation with **Temperature** 

Figure 6. Threshold Voltage Variation with **Temperature** 

#### TYPICAL CHARACTERISTICS

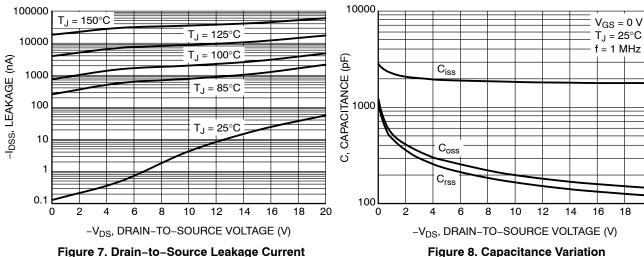


Figure 7. Drain-to-Source Leakage Current vs. Voltage

 $V_{GS}$ 

 $V_{DS} = -10 \text{ V}$   $I_{D} = -5.1 \text{ A}$   $T_{J} = 25^{\circ}\text{C}$ 

14

16

18

 $Q_T$ 

V<sub>DS</sub>

 $Q_{gd}$ 

6

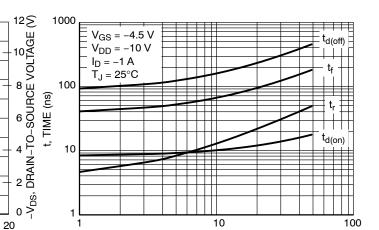
8

-V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (V)

Q<sub>gs</sub>

2 4

0



20

Figure 9. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

12

10

Q<sub>q</sub>, TOTAL GATE CHARGE (nC)

 $\label{eq:RG} \textbf{R}_{G},\, \textbf{GATE RESISTANCE}\,\,(\Omega)$  Figure 10. Resistive Switching Time Variation vs. Gate Resistance

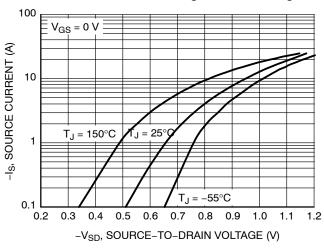


Figure 11. Diode Forward Voltage vs. Current

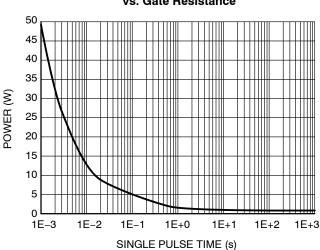


Figure 12. Single Pulse Maximum Power Dissipation

# **TYPICAL CHARACTERISTICS**

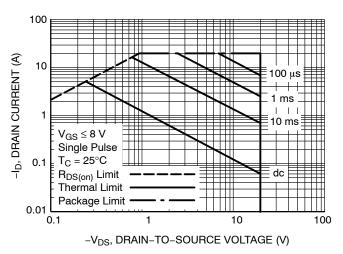


Figure 13. Maximum Rated Forward Biased Safe Operating Area

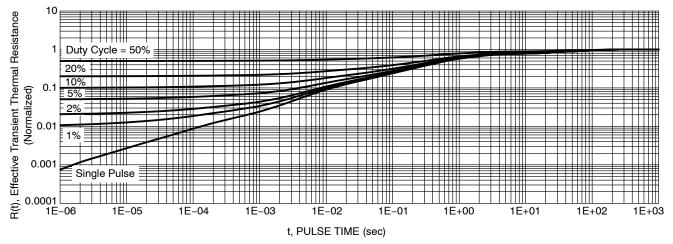
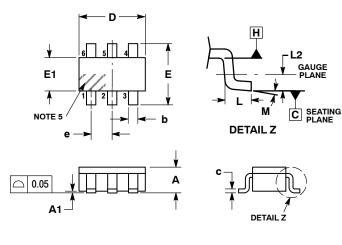


Figure 14. Thermal Response

#### PACKAGE DIMENSIONS

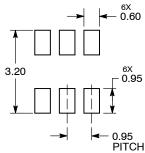
#### TSOP-6 CASE 318G-02 ISSUE V



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM
  LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
- DIMENSIONS D AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSIONS D AND E1 ARE DETERMINED AT DATUM H.
- 5. PIN ONE INDICATOR MUST BE LOCATED IN THE INDICATED ZONE.

	MILLIMETERS			
DIM	MIN	NOM	MAX	
Α	0.90	1.00	1.10	
A1	0.01	0.06	0.10	
b	0.25	0.38	0.50	
С	0.10	0.18	0.26	
D	2.90	3.00	3.10	
E	2.50	2.75	3.00	
E1	1.30	1.50	1.70	
е	0085	0.95	11.005	
L	0.20	0.40	0.60	
L2	0.25 BSC			
М		_		

#### **RECOMMENDED SOLDERING FOOTPRINT\***



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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